FAN4146

Ground Fault Interrupter

Description

The FAN4146 is a low-power controller for AC outlet Appliance Leakage Circuit Interrupters (ALCI) and two-wire Residual Current Devices (RCD). The FAN4146 detects hazardous grounding conditions and open circuits the line before a harmful shock occurs.

Internally, the FAN4146 contains a diode rectifier, precision bandgap 12 V shunt regulator, precision low V_{OS} offset-sense amplifier, time delay noise filter, window-detection comparators, and a SCR driver. With the addition of a minimum number of external components, the FAN4146 detects and protects against a hot-wire-to-ground fault. The minimum number of components and the small SUPERSOT™ package allow for a small-form-factor, low-cost application solution.

The FAN4146 circuitry has a built-in rectifier and shunt regulator that operates with a low quiescent current. This allows for a high-value, low-wattage-series supply resistor. The internal temperature compensated shunt regulator, sense amplifier, and bias circuitry provide for precision ground-fault detection. The low V_{OS} offset-sense amplifier allows direct coupling of the sense coil to the amplifier’s feedback signal. This eliminates the large 50/60 Hz AC-coupling capacitor. The internal delay filter rejects high-frequency noise spikes common with inductive loads. This decreases false nuisance tripping. The internal SCR driver is temperature compensated and designed to satisfy the current requirements for a wide selection of external SCRs.

The minimum number of external components and the 6-pin SUPERSOT package enable for a low-cost, compact design and layout. The FAN4146ESX is an enhanced temperature range device.

Features

- For Two-wire ALCI and RCD Applications
- Precision Sense Amplifier and Bandgap Reference
- Built-in AC Rectifier
- Direct DC Coupled to Sense Coil
- Built-in Noise Filter
- Low-voltage SCR Disable
- SCR Gate Driver
- Adjustable Sensitivity
- Minimum External Components
- Meets UL 943B Requirements
- Ideal for 120 V or 220 V Systems
- Space-saving SUPERSOT 6-pin Package
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Personal Care Products
- Two-wire Electrical Outlets, Circuit Breakers, and Power Cords Requiring GFI Safety Features
- ALCI and RCCB Circuits
**Typical Values:**

1. **R1:** 91 kΩ (Wattage Determined by Maximum VAC)
2. **RTEST:** 15 kΩ
3. **RSET:** 511 kΩ (Note 1)
4. **RIN:** 470 kΩ
5. **C1:** 22 nF

**Notes:**
1. Value depends on sense-coil characteristics and application (value chosen for 5 mA trip threshold).
2. Contact ON Semiconductor for best application practices for nuisance tripping rejection.

**Figure 1. 120/220 VAC ALCI Application** (Note 2)

**Typical Values:**

1. **R1:** 174 kΩ (Wattage Determined by Maximum VAC)
2. **RTEST:** 15 kΩ
3. **RSET:** 324 kΩ (Note 3)
4. **RIN:** 470 kΩ
5. **C1:** 22 nF
6. **C2:** 10 nF

**Notes:**
1. Value depends on sense-coil characteristics and application (value chosen for 10 mA trip threshold).
2. Contact ON Semiconductor for best application practices for nuisance tripping rejection.

**Figure 2. 220 VAC RCD Application** (Note 4)
FAN4146

BLOCK DIAGRAM

Figure 3. Block Diagram

PIN CONFIGURATION

Figure 4. Pin Configuration

PIN DEFINITIONS

<table>
<thead>
<tr>
<th>Pin #</th>
<th>Name</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>SCR</td>
<td>Gate drive for external SCR</td>
</tr>
<tr>
<td>2</td>
<td>Neutral</td>
<td>Supply input for FAN4146 circuitry</td>
</tr>
<tr>
<td>3</td>
<td>Line</td>
<td>Supply input for FAN4146 circuitry</td>
</tr>
<tr>
<td>4</td>
<td>VREF</td>
<td>Non-inverting input for current-sense amplifier</td>
</tr>
<tr>
<td>5</td>
<td>VFB</td>
<td>Inverting input for current-sense amplifier</td>
</tr>
<tr>
<td>6</td>
<td>AmpOut</td>
<td>External resistor connected to VFB sets the Ifault sensitivity threshold</td>
</tr>
</tbody>
</table>
### ABSOLUTE MAXIMUM RATINGS

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Condition</th>
<th>Min</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>ICC</td>
<td>Supply Current</td>
<td>Continuous Current, Line to Neutral</td>
<td>–</td>
<td>15</td>
<td>mA</td>
</tr>
<tr>
<td>VCC</td>
<td>Supply Voltage</td>
<td>Continuous Voltage, Line to Neutral</td>
<td>–1.5</td>
<td>16.0</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td>All other pins</td>
<td>Continuous Voltage to Neutral</td>
<td>–0.8</td>
<td>15.0</td>
<td>V</td>
</tr>
<tr>
<td>TSTG</td>
<td>Storage Temperature Range</td>
<td>–65</td>
<td>+150</td>
<td>°C</td>
<td></td>
</tr>
<tr>
<td>ESD</td>
<td>Electrostatic Discharge Capability</td>
<td>Human Body Model, JESD22–A114</td>
<td>–</td>
<td>2500</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Charged Device Model, JESD22–C101</td>
<td>–</td>
<td>1000</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>Machine Model, JESD22–A115</td>
<td>–</td>
<td>200</td>
<td></td>
</tr>
</tbody>
</table>

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### DC ELECTRICAL CHARACTERISTICS

(Unless otherwise specified, $T_A = 25°C, I_{shunt} = 1 mA$)

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Condition</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>VREG</td>
<td>Power Supply Shunt Regulator Voltage</td>
<td>Line to Neutral</td>
<td>12.2</td>
<td>12.7</td>
<td>13.2</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>Line to Neutral, $I_{shunt} = –2 mA$</td>
<td>–0.9</td>
<td>–0.7</td>
<td>–</td>
<td>V</td>
</tr>
<tr>
<td>IQ</td>
<td>Quiescent Current</td>
<td>Line to Neutral = 10 V</td>
<td>350</td>
<td>400</td>
<td>450</td>
<td>μA</td>
</tr>
<tr>
<td>VREF</td>
<td>Reference Voltage</td>
<td>$V_{REF}$ to Neutral</td>
<td>5.8</td>
<td>6.0</td>
<td>6.2</td>
<td>V</td>
</tr>
<tr>
<td>VTH</td>
<td>Trip Threshold</td>
<td>AmpOut to $V_{REF}$</td>
<td>3.4</td>
<td>3.5</td>
<td>3.6</td>
<td>V</td>
</tr>
<tr>
<td>VOS</td>
<td>Amplifier Offset</td>
<td>$R_{SET} = 511 kΩ, R_{IN} = 500 Ω$</td>
<td>–450</td>
<td>0</td>
<td>450</td>
<td>μV</td>
</tr>
<tr>
<td>IOS</td>
<td>Amplifier Input Offset (Note 5)</td>
<td>Design Value</td>
<td>–50</td>
<td>0</td>
<td>50</td>
<td>nA</td>
</tr>
<tr>
<td>G</td>
<td>Amplifier DC Gain (Note 5)</td>
<td>Design Value</td>
<td>–</td>
<td>100</td>
<td>–</td>
<td>dB</td>
</tr>
<tr>
<td>fGBW</td>
<td>Amplifier Gain Bandwidth (Note 5)</td>
<td>Design Value</td>
<td>–</td>
<td>1.5</td>
<td>–</td>
<td>MHz</td>
</tr>
<tr>
<td>VSW+</td>
<td>Amplifier Positive Voltage Swing</td>
<td>AmpOut to $V_{REF}$, $I_{FAULT} = 10 μA$</td>
<td>4.0</td>
<td>–</td>
<td>–</td>
<td>V</td>
</tr>
<tr>
<td>VSW−</td>
<td>Amplifier Negative Voltage Swing</td>
<td>$V_{REF}$ to AmpOut, $I_{FAULT} = –10 μA$</td>
<td>4.0</td>
<td>–</td>
<td>–</td>
<td>V</td>
</tr>
<tr>
<td>ISINK</td>
<td>Amplifier Current Sink</td>
<td>AmpOut = $V_{REF} + 3 V$, $V_{FB} = V_{REF} + 100 mV$</td>
<td>400</td>
<td>–</td>
<td>–</td>
<td>μA</td>
</tr>
<tr>
<td>ISRL</td>
<td>Amplifier Current Source</td>
<td>AmpOut = $V_{REF} – 3 V$, $V_{FB} = V_{REF} – 100 mV$</td>
<td>400</td>
<td>–</td>
<td>–</td>
<td>μA</td>
</tr>
<tr>
<td>td</td>
<td>Delay Filter</td>
<td>Delay from $C_1$ Trip to SCR, LOW to HIGH</td>
<td>0.75</td>
<td>1.00</td>
<td>1.25</td>
<td>ms</td>
</tr>
<tr>
<td>ROUT</td>
<td>SCR Output Resistance</td>
<td>SCR to Neutral = 250 mV, AmpOut = $V_{REF}$</td>
<td>–</td>
<td>0.5</td>
<td>1.0</td>
<td>kΩ</td>
</tr>
<tr>
<td>VOUT</td>
<td>SCR Output Voltage</td>
<td>SCR to Neutral, AmpOut = $V_{REF}$</td>
<td>–</td>
<td>1</td>
<td>10</td>
<td>mV</td>
</tr>
<tr>
<td></td>
<td></td>
<td>SCR to Neutral, AmpOut = $V_{REF} + 4 V$</td>
<td>2.5</td>
<td>–</td>
<td>–</td>
<td>V</td>
</tr>
<tr>
<td>IOUT</td>
<td>SCR Output Current</td>
<td>SCR to Neutral = 1 V, AmpOut = $V_{REF} + 4 V$</td>
<td>350</td>
<td>500</td>
<td>–</td>
<td>μA</td>
</tr>
</tbody>
</table>

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Guaranteed by design; not tested in production.
The FAN4146 is a two-wire GFCI controller for AC ground-fault-circuit interrupters. The internal rectifier circuit is biased by the AC line during the positive half cycle of the AC line voltage. The internal 12 V shunt regulator uses a precision temperature-compensated bandgap reference. The combination of precision reference circuitry and precision sense amplifier provides for an accurate ground-fault tolerance. This allows for selection of external components with wider and lower-cost parameter variation. Due to the low quiescent current, a high value external series resistor (R₁) can be used which reduces the maximum power wattage required for this resistor. The 12 V shunt regulator generates the reference voltage V\textsubscript{REF} for the sense amplifier’s (A₁) non-inverting input (AC ground reference) and supplies the bias for the delay timer (t₁), comparators (C₁ & C₂), and the SCR driver.

The secondary winding of the sense transformer is directly DC coupled to the inverting input of the sense amplifier at pin 5 (V\textsubscript{FB}). The R\textsubscript{SET} resistor converts the sense transformer’s secondary current to a voltage at pin 6 (AmpOut). This voltage is compared to the internal window comparator (C₁ & C₂) and, when the AmpOut voltage exceeds the ±V\textsubscript{TH} threshold voltage, the window comparator triggers the internal delay timer. The output of the window comparator must stay HIGH for the duration of the t₁ pulse. If the window comparator’s output momentarily goes LOW, the t₁ timer resets. If the window comparator’s output is still HIGH at the end of the t₁ pulse, the SCR driver enables the current source I₁ and disables Q₁. The current source I₁ then enables the external SCR, which energizes the solenoid, opens the contact switches to the load, and removes the hazardous ground fault. The window comparator allows detection of a positive or negative I\textsubscript{FAULT} signal independent from the phase of the line voltage. An internal under-voltage lockout circuit disables the SCR driver if the voltage at pin 3 (LINE) is below 7.5 V. This prevents the SCR from energizing the solenoid when the SCR’s anode voltage is below 65 V.

The sense transformer typically has a toroidal core made of laminated steel rings or solid ferrite material. The secondary of the transformer is typically 1000 turns of #40 wire wound through the toroid. The primary is typically one turn made by passing the AC hot and neutral wires through the center of the toroid. When a ground fault exists, a difference exists between the current flowing in hot and neutral wires. The primary difference current divided by the primary-to-secondary turns ratio is the current that flows through the secondary wire of the transformer.

### Calculation of R\textsubscript{SET} Resistor

The AmpOut signal must exceed the window comparator’s V\textsubscript{TH} threshold voltage for longer than the delay timer and calculated by:

\[
V_{\text{TH}} = I_{\text{FAULT}} \times 1.41 \times R_{\text{SET}} \times \cos \left( \frac{2\pi \times \frac{t}{2P}}{N} \right) \\
R_{\text{SET}} = \frac{V_{\text{TH}} \times N}{1.41 \times I_{\text{FAULT}} \times \cos \left( \pi \times \frac{1}{P} \right)}
\]

where:
- \(V_{\text{TH}} = 3.5\) V
- \(I_{\text{FAULT}} = 5\) mA (UL943B)
- \(t = 1\) ms (timer delay)
- \(P =\) Period of the AC Line (1/60 Hz)
- \(N =\) Ratio of secondary to primary turns (1000:1)
- \(R_{\text{SET}} = 505\) kΩ (511 kΩ standard 1% value).

In practice, the transformer is non-ideal, so R\textsubscript{SET} may need to be adjusted by up to 30% to obtain the desired I\textsubscript{FAULT} trip threshold.

### Calculation of V\textsubscript{OS} Trip Threshold Error

Since the sense coil is directly connected to the feedback of the sense amplifier, the V\textsubscript{OS} offset introduces an I\textsubscript{FAULT} trip threshold error. This error can be calculated as follows:

\[
\%\text{Error} = 100 \times \frac{R_{\text{IN}} + R_{\text{LC}}} {V_{\text{TH}}} 
\]

where:
- \(V_{\text{OS}} =\) ±450 μV (worst case)
  = ±150 μV (typical)
- \(R_{\text{SET}} = 511\) kΩ
- \(R_{\text{IN}} = 470\) Ω (typical value)
- \(R_{\text{LC}} = 75\) Ω (sense coil secondary DC resistance)
- \(R_{\text{AC}} = 1.5\) kΩ (AC(\text{rms}) impedance of sense coil), \(L = 4\) H, \(f = 60\) Hz
- \(V_{\text{TH}} = 3.5\) V

\%\text{Error} = ±3.2% (worst case)
  = ±1.1% (typical).
TYPICAL PERFORMANCE CHARACTERISTICS

(Unless otherwise specified, $T_A = 25^\circ C$ and according to Figure 1 with SCR disconnected.)

Figure 5. Typical Waveforms, No Ground Fault

Ch1: $V_{\text{Line}}$ (Pin 3), 10 V/Div
Ch2: $V_{\text{AmpOut}}$ (Pin 6), 10 V/Div
Ch3: $V_{\text{REF}}$ (Pin 4), 10 V/Div
Ch4: $V_{\text{AC Input}}$, 200 V/Div

Figure 6. Typical Waveforms, 4 mA Ground Fault

Ch1: $V_{\text{Line}}$ (Pin 3), 10 V/Div
Ch2: $V_{\text{AmpOut}}$ (Pin 6), 5 V/Div
Ch3: $V_{\text{SCR}}$ (Pin 1), 1 V/Div
Ch4: $I_{\text{FAULT}}$, 10 mA/Div

Figure 7. Typical Waveforms, 5 mA Ground Fault

Ch1: $V_{\text{Line}}$ (Pin 3), 10 V/Div
Ch2: $V_{\text{AmpOut}}$ (Pin 6), 5 V/Div
Ch3: $V_{\text{SCR}}$ (Pin 1), 1 V/Div
Ch4: $I_{\text{FAULT}}$, 10 mA/Div

Figure 8. Typical Waveforms, 5 mA Ground Fault (Line Polarity Reversal)

Ch1: $V_{\text{Line}}$ (Pin 3), 10 V/Div
Ch2: $V_{\text{AmpOut}}$ (Pin 6), 5 V/Div
Ch3: $V_{\text{SCR}}$ (Pin 1), 1 V/Div
Ch4: $I_{\text{FAULT}}$, 10 mA/Div
TYPICAL PERFORMANCE CHARACTERISTICS (Continued)
(Unless otherwise specified, $T_A = 25^\circ C$ and according to Figure 1 with SCR disconnected.)

Figure 9. AmpOut Threshold, Internal 1 ms Delay

1 ms after AmpOut signal reaches 9.5 V, SCR is triggered.

Ch1: $V_{Line}$ (Pin 3), 10 V/Div
Ch2: AmpOut (Pin 6), 5 V/Div
Ch3: SCR (Pin 1), 1 V/Div
Ch4: $I_{FAULT}$, 10 mA/Div

Figure 10. 15 kΩ Ground Fault

Ch1: $V_{Line}$ (Pin 3), 10 V/Div
Ch2: AmpOut (Pin 6), 5 V/Div
Ch3: SCR (Pin 1), 2 V/Div
Ch4: $I_{FAULT}$, 10 mA/Div

Figure 11. 500 Ω Ground Fault (Notes 6, 7)

Ch1: $V_{Line}$ (Pin 3), 10 V/Div
Ch2: AmpOut (Pin 6), 5 V/Div
Ch3: SCR (Pin 1), 2 V/Div
Ch4: $I_{FAULT}$, 500 mA/Div

Notes:
6. Maximum trip time ~12 ms.
7. Fault occurs at the end of the positive AC cycle.
TYPICAL TEMPERATURE CHARACTERISTICS (FAN4146E)

Figure 12. VThreshold ($V_{TH}$) vs. Temperature

Figure 13. VReference ($V_{REF}$) vs. Temperature

Figure 14. SCR Output Current ($I_{OUT}$) vs. Temperature
## ORDERING INFORMATION

<table>
<thead>
<tr>
<th>Part Number</th>
<th>Operating Temperature Range</th>
<th>Package</th>
<th>Shipping (Qty / Packing)†</th>
</tr>
</thead>
<tbody>
<tr>
<td>FAN4146SX</td>
<td>0°C to +70°C</td>
<td>TSOT23 6-Lead (Pb-Free)</td>
<td>3,000 / Tape &amp; Reel</td>
</tr>
<tr>
<td>FAN4146ESX</td>
<td>−35°C to +85°C</td>
<td>TSOT23 6-Lead (Pb-Free)</td>
<td>3,000 / Tape &amp; Reel</td>
</tr>
</tbody>
</table>

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

SUPERSOT is a trademark of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries.
MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS

TSOT23 6–Lead
CASE 419BL
ISSUE A

DATE 31 AUG 2020

NOTES:
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.25MM PER SIDE. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H.
4. SEATING PLANE IS DEFINED BY THE TERMINALS. "A" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

<table>
<thead>
<tr>
<th>DIM</th>
<th>MILLIMETERS</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
</tr>
</thead>
<tbody>
<tr>
<td>A</td>
<td>0.90</td>
<td>1.00</td>
<td>1.10</td>
<td></td>
</tr>
<tr>
<td>A1</td>
<td>0.05</td>
<td>0.05</td>
<td>0.10</td>
<td></td>
</tr>
<tr>
<td>A2</td>
<td>0.70</td>
<td>0.85</td>
<td>1.00</td>
<td></td>
</tr>
<tr>
<td>A3</td>
<td>0.25</td>
<td>0.25</td>
<td>0.38</td>
<td></td>
</tr>
<tr>
<td>b</td>
<td>0.25</td>
<td>0.38</td>
<td>0.50</td>
<td></td>
</tr>
<tr>
<td>c</td>
<td>0.10</td>
<td>0.18</td>
<td>0.26</td>
<td></td>
</tr>
<tr>
<td>D</td>
<td>2.80</td>
<td>2.95</td>
<td>3.10</td>
<td></td>
</tr>
<tr>
<td>d</td>
<td>0.30</td>
<td>0.30</td>
<td>0.30</td>
<td></td>
</tr>
<tr>
<td>e</td>
<td>1.90</td>
<td>1.90</td>
<td>1.90</td>
<td></td>
</tr>
<tr>
<td>L1</td>
<td>0.60</td>
<td>0.60</td>
<td>0.60</td>
<td></td>
</tr>
<tr>
<td>L2</td>
<td>0.20</td>
<td>0.40</td>
<td>0.60</td>
<td></td>
</tr>
</tbody>
</table>

SCALE 2:1

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

LAND PATTERN RECOMMENDATION

 generic

XXX = Specific Device Code
M = Date Code
• = Pb–Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER: 98AON83292G
DESCRIPTION: TSOT23 6–Lead

Electronic versions are uncontrolled except when accessed directly from the Document Repository.
Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.

© Semiconductor Components Industries, LLC, 2018
www.onsemi.com